



General Description

- Trench Power AlphaSGT™ Technology
- Low $R_{DS(ON)}$
- $T_J=175^{\circ}\text{C}$ rated
- Low Thermal Resistance
- Top Cooling
- Standard Level Gate Threshold
- RoHS 2.0 and Halogen-Free Compliant

Applications

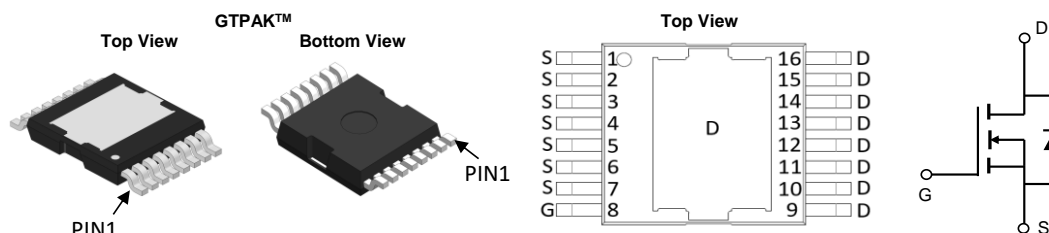
- Motor
- Battery Manangement

Product Summary

V_{DS}	100V
I_D (at $V_{GS}=10\text{V}$)	397A
$R_{DS(ON)}$ (at $V_{GS}=10\text{V}$)	< 1.2m Ω
$R_{DS(ON)}$ (at $V_{GS}=8\text{V}$)	< 1.4m Ω

100% UIS Tested
100% Rg Tested

Max $T_J=175^{\circ}\text{C}$



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOGT68905	GTPAK™	Tape & Reel	1800

Absolute Maximum Ratings $T_A=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^G	I_D	397	A
		293	
Pulsed Drain Current ^C	I_{DM}	1588	
Avalanche Current ^C	I_{AS}	100	A
Avalanche energy L=0.1mH ^C	E_{AS}	500	mJ
Power Dissipation ^B	P_D	428	W
		214	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	$^{\circ}\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	10	15	$^{\circ}\text{C/W}$
Maximum Junction-to-Ambient ^{A, D}		32	40	$^{\circ}\text{C/W}$
Maximum Junction-to-Case	$R_{\theta JC}$	0.25	0.35	$^{\circ}\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	100			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	2.3	2.7	3.3	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A T _J =125°C		1 1.7	1.2 2.1	mΩ
		V _{GS} =8V, I _D =20A		1.1	1.4	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A		92		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.65	1	V
I _S	Maximum Body-Diode Continuous Current				200	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz		10600		pF
C _{oss}	Output Capacitance			4600		pF
C _{rss}	Reverse Transfer Capacitance			50		pF
R _g	Gate resistance	f=1MHz	0.8	1.7	2.6	Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A		139	200	220
Q _{gs}	Gate Source Charge			40		nC
Q _{gd}	Gate Drain Charge			28		nC
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =50V		362		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =50V, R _L =2.5Ω, R _{GEN} =3Ω		27		ns
t _r	Turn-On Rise Time			23		ns
t _{D(off)}	Turn-Off DelayTime			104		ns
t _f	Turn-Off Fall Time			47		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		61		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		450		nC

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} ≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature T_{J(MAX)}=175° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

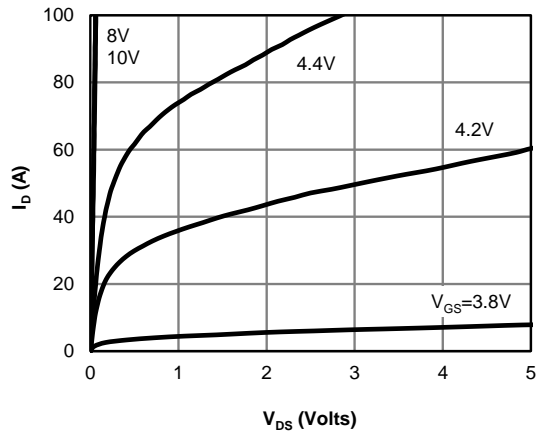


Figure 1: On-Region Characteristics (Note E)

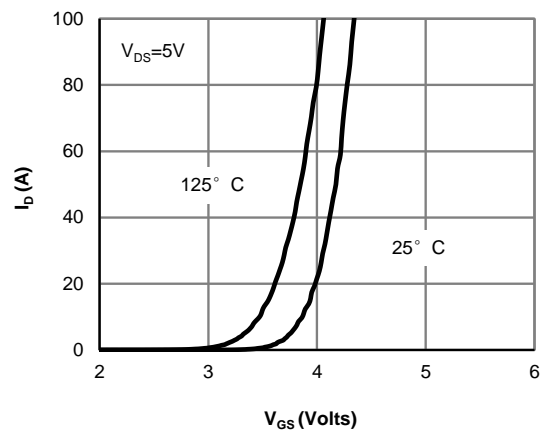


Figure 2: Transfer Characteristics (Note E)

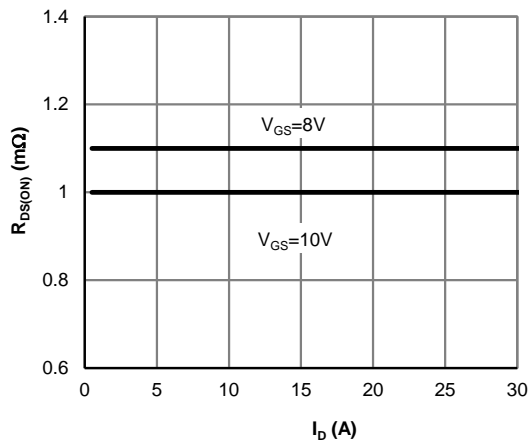


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

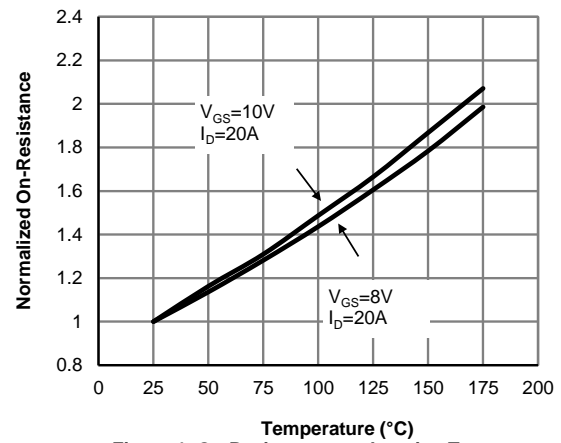


Figure 4: On-Resistance vs. Junction Temperature (Note E)

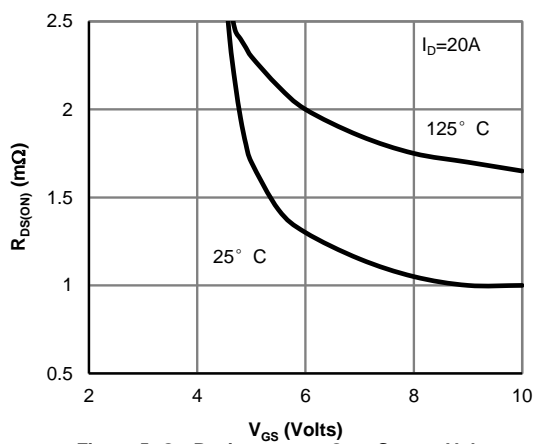


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

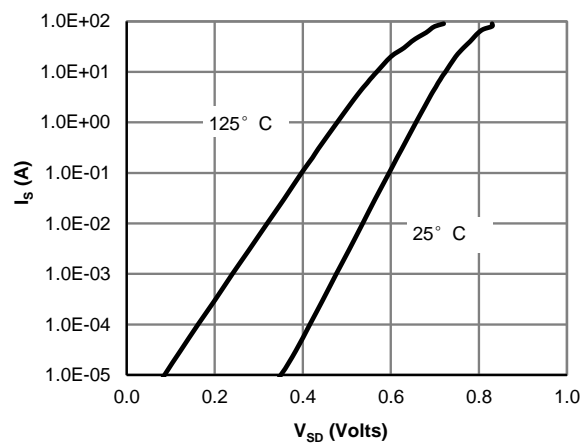
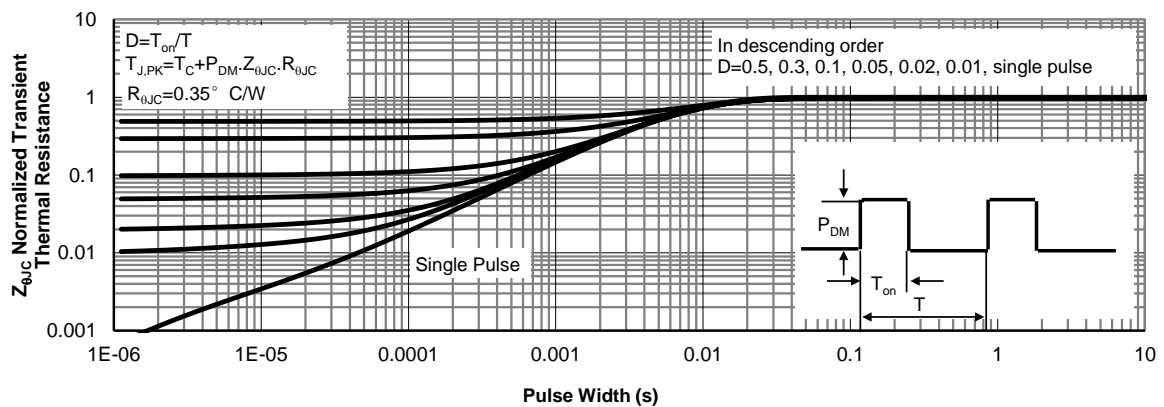
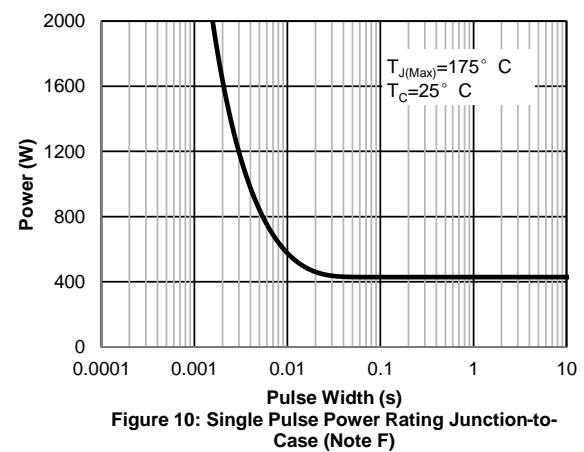
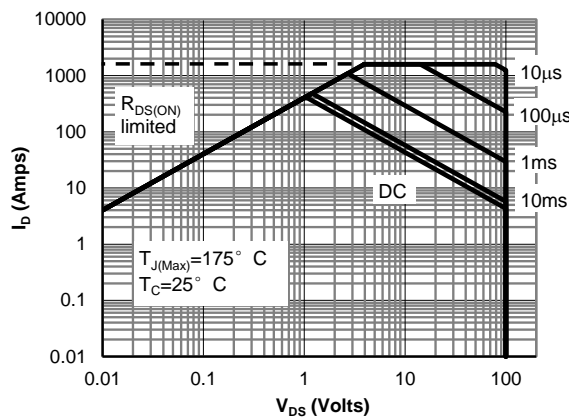
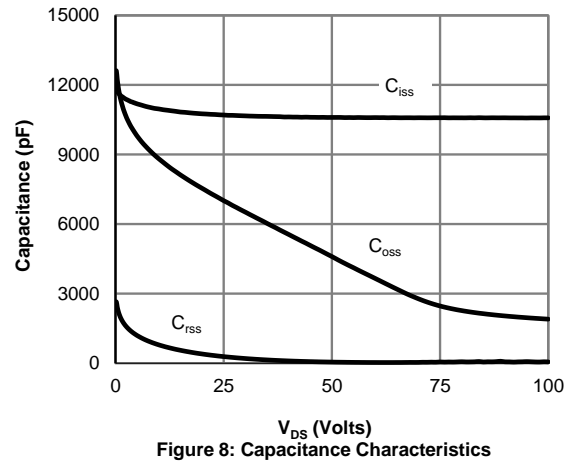
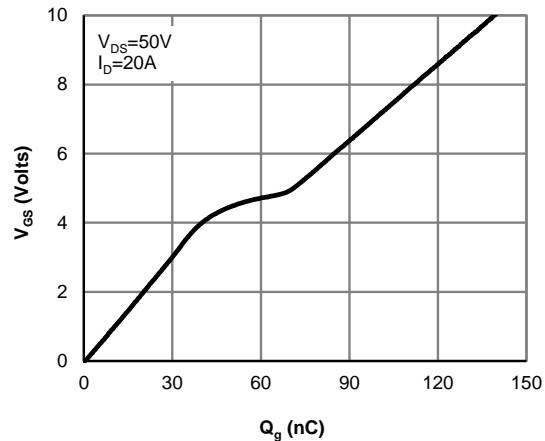


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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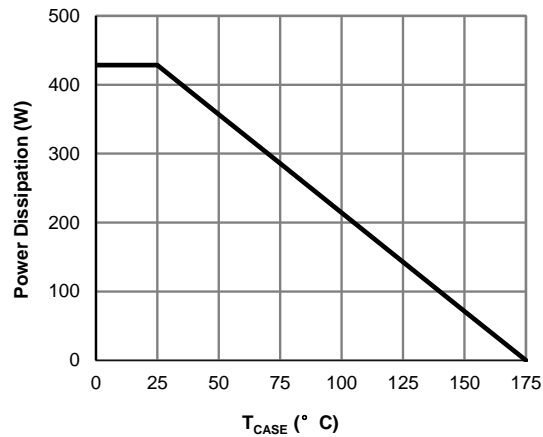


Figure 12: Power De-rating (Note F)

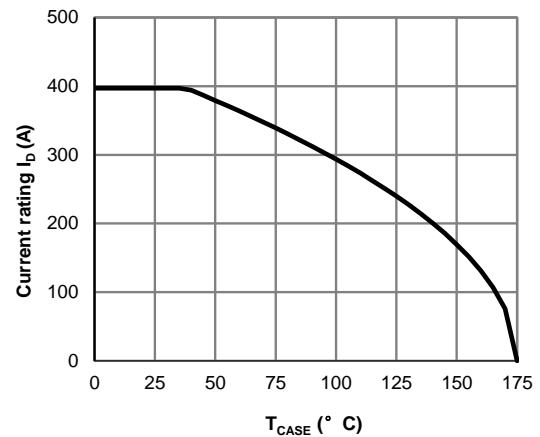


Figure 13: Current De-rating (Note F)

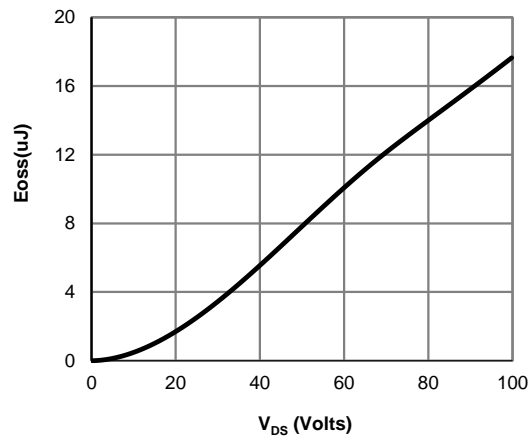


Figure 14: Coss stored Energy

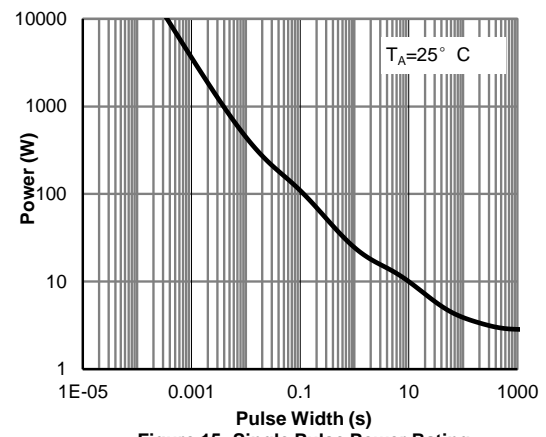


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

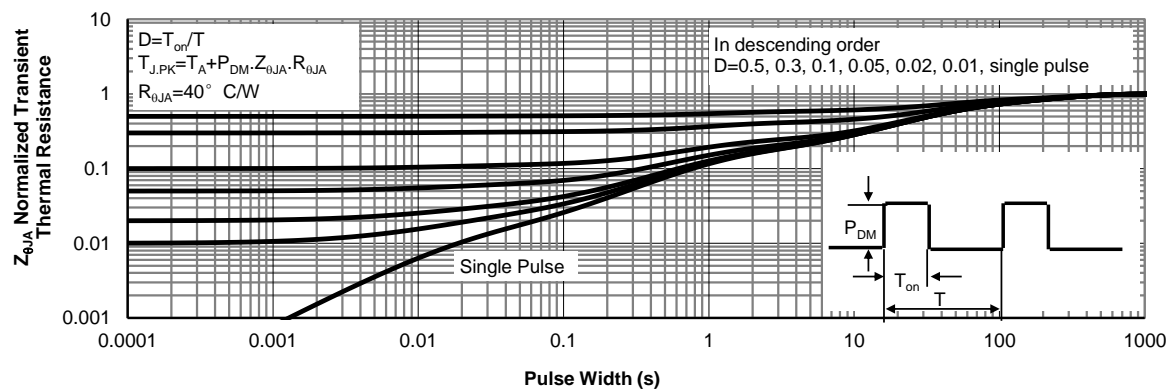


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

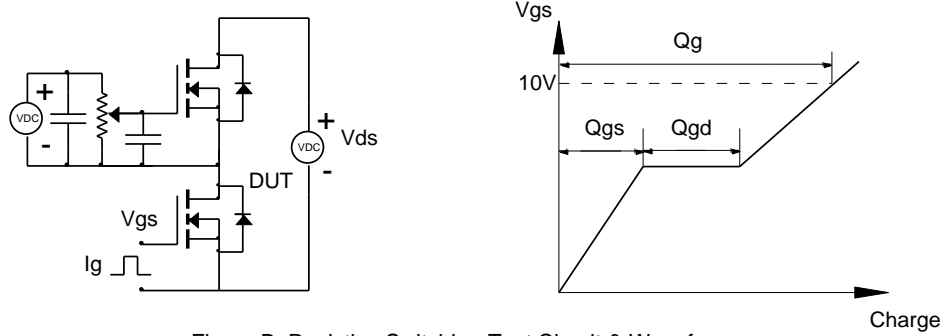


Figure B: Resistive Switching Test Circuit & Waveforms

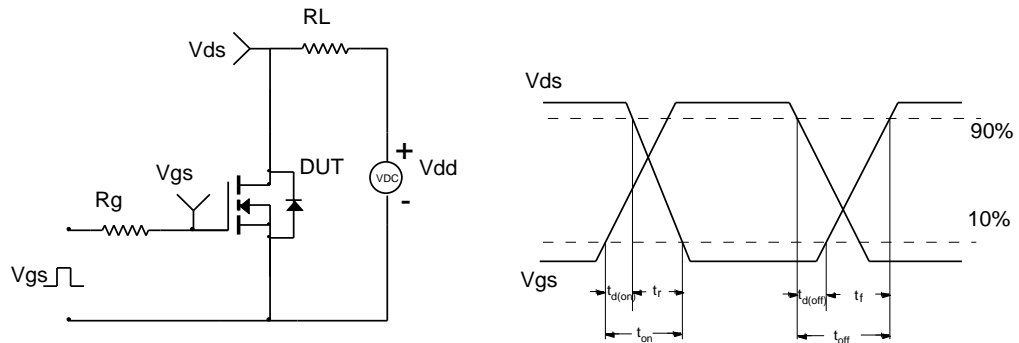


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

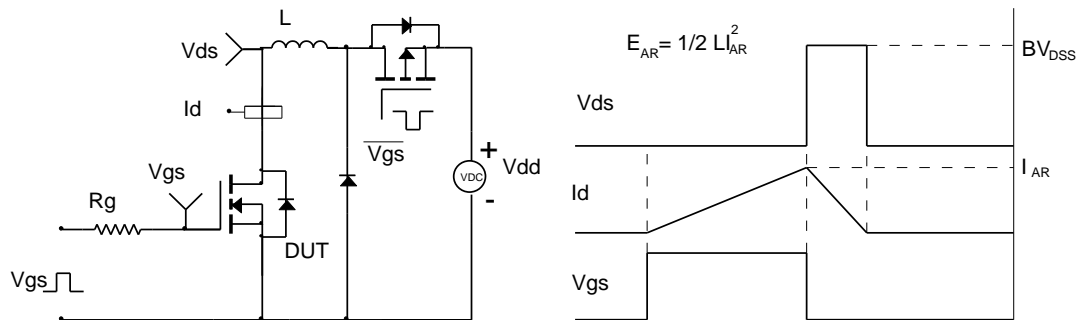


Figure D: Diode Recovery Test Circuit & Waveforms

